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# Small-Angle X-ray Scattering Basics & Applications

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### Overview

- Introduction

  - ✤ History
  - Application field of SAXS
- Theory
  - Structural Information obtained by SAXS
- Experimental Methods
  - Optics
  - Detectors
- Advanced SAXS
  - ∞ Microbeam, GI-SAXS, USAXS, XPCS etc...



# What's Small-Angle X-ray Scattering ?





crystalline sample --> small-angle X-ray diffraction: SAXD solution scattering / inhomogeneous structure --> SAXS



# History of SAXS (< 1936)

Krishnamurty (1930) Hendricks (1932)

Mark (1932)

Warren (1936)



carbon black

Observation of scattering

from powders, fibers, and colloidal dispersions



Molten silica - silica gel



# History (> 1936)





### <u>A. Guinier</u> (1937, 1939, 1943)

Interpretation of inhomogeneities in Al alloys "G-P zones", introducing the concept of "particle scattering" and formalism necessary to solve the problem of a diluted system of particles.

### <u>O. Kratky</u> (1938, 1942, 1962)

### <u>**G.** Porod</u> (1942, 1960, 1961)

Description of dense systems of colloidal particles, micelles, and fibers.

Macromolecules in solution.





Single crystals of Al-Cu hardened alloy

### **Application of SAXS**







Typical SAXS image



Proteins in solution (Dr. Svergun, EMBL)





Nanocomposite

### **Application of SAXS**

- Size and form of particulate system
  - ✤ Colloids, Globular proteins, etc...
- Inhomogeneous structure
  - Polymer chain, two-phase system etc.
- Distorted crystalline structure
  - Crystal of soft matter



### SAXS of particulate system



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### Basic of X-ray scattering



Fourier transform of electron density

Scattering intensity per unit volume: 
$$I(q) = \frac{A(q)A^*(q)}{V}$$



Correlation function of electron density per unit volume

$$\gamma(\mathbf{r}) = \frac{1}{V} \int_{V} \rho(\mathbf{r}') \rho(\mathbf{r} + \mathbf{r}') d\mathbf{r}' = \frac{1}{V} \frac{P(\mathbf{r})}{Patterson Function}$$

(Debye & Bueche 1949)

asymptotic behavior of the correlation function

$$\gamma(\mathbf{r}=0) = \langle \rho^2 \rangle \qquad \gamma(\mathbf{r} \to \infty) \to \langle \rho \rangle^2$$

Scattering Intensity : Fourier Transform of correlation function

$$I(\boldsymbol{q}) = \int_{V} \gamma(\boldsymbol{r}) \exp\left(-\mathrm{i}\boldsymbol{q}\cdot\boldsymbol{r}\right) \mathrm{d}\boldsymbol{r}$$



### **Real space and Reciprocal Space**



# **Diffraction from Lamellar Structure**



### Normalized Correlation Function

Local electron density fluctuations:  $\eta(\mathbf{r}) = \rho(\mathbf{r}) - \langle \rho \rangle$  $\longrightarrow \langle \eta^2 \rangle = \langle (\rho(\mathbf{r}) - \langle \rho \rangle)^2 \rangle = \langle \rho^2 \rangle - \langle \rho \rangle^2$ 

average density fluctuaitons

Normalized Correlation Function

$$I(\boldsymbol{q}) = \langle \eta^2 \rangle \int_V \gamma_0(\boldsymbol{r}) \mathrm{e}^{-\mathrm{i}\boldsymbol{q}\cdot\boldsymbol{r}} \mathrm{d}\boldsymbol{r} + \langle \rho \rangle^2 \delta(\boldsymbol{q})$$

Only the average density fluctuations contribute to the signal.

Not observable.

### Invariant Q

$$I(q) = \langle \eta^2 \rangle \int_V \gamma_0(r) e^{-iq \cdot r} dr + \langle \rho \rangle^2 \delta(q)$$
  
Parseval's equality  

$$\int I(q) dq = (2\pi)^3 \langle \eta^2 \rangle$$
  

$$4\pi \int I(q) q^2 dq$$
Parseval's equality  

$$A(q) \stackrel{\text{Fourier Trans.}}{\leftarrow} \eta(r)$$
  

$$\int |A(q)|^2 dq = (2\pi)^3 \int |\eta(r)|^2 dr$$
  
Invariant:  $Q = \int_0^\infty I(q) q^2 dq = 2\pi^2 \langle \eta^2 \rangle$ 



### Spherical sample





### Homogeneous sphere

$$I(q) = \frac{(\Delta \rho)^2 V_{\text{particle}}^2}{V} \left[ 3 \frac{\sin qR - qR \cos qR}{(qR)^3} \right]$$



isotropic scattering



### Homogeneous elipsiod

# Fixed particle Random orientation

### anisotropic scattering

isotropic scattering



# Size distribution



### Radius of Gyration -- Guinier Plot



Guinier plot: log (I(q)) vs  $q^2$ 

O. Glatter & O. Kratky ed., "Small Angle X-ray Scattering", Academic Press (1982).

# Structure Factor & Form Factor



### **Proposed remedy:**

• GIFT (Generalized Inverse Fourier Trans.) by O. Glatter



### Scattering from Inhomogeneous Structure



### Two-phase system

Phase 1:  $\rho_1$ , volume fraction  $\phi$  Phase 2:  $\rho_2$  volume fraction 1 -  $\phi$ 

$$A(\boldsymbol{q}) = \int_{\phi V} \rho_1 e^{-i\boldsymbol{q}\cdot\boldsymbol{r}} d\boldsymbol{r} + \int_{(1-\phi)V} \rho_2 e^{-i\boldsymbol{q}\cdot\boldsymbol{r}} d\boldsymbol{r}$$
$$= \int_{\phi V} (\rho_1 - \rho_2) e^{-i\boldsymbol{q}\cdot\boldsymbol{r}} d\boldsymbol{r} + \rho_2 \int_V e^{-i\boldsymbol{q}\cdot\boldsymbol{r}} d\boldsymbol{r}$$
$$A(\boldsymbol{q}) = \int_V \Delta \rho e^{-i\boldsymbol{q}\cdot\boldsymbol{r}} d\boldsymbol{r} + \rho_2 \delta(\boldsymbol{q})$$







Two complementary structures produce the same scattering.

Averaged square fluctuation of electron density

$$\langle \eta^2 \rangle = \phi (1 - \phi) (\Delta \rho)^2$$
 where  $\Delta \rho = \rho_1 - \rho_2$ 

$$I(q) = 4\pi \langle \eta^2 \rangle \int_0^\infty \gamma_0(r) \frac{\sin(qr)}{qr} r^2 dr$$
$$I(q) = 4\pi \phi (1-\phi) (\Delta \rho)^2 \int_0^\infty \gamma_0(r) \frac{\sin(qr)}{qr} r^2 dr$$

$$Q = \int_0^\infty I(q)q^2 dq = 2\pi^2 \phi (1-\phi) (\Delta \rho)^2$$

**Invariant**: does not depend on the structure of the two phases but only on the volume fractions and the contrast between the two phases.



### Porod's law

For a sharp interface, the scattered intensity decreases as q<sup>-4</sup>.

$$I(q) \rightarrow (\Delta \rho)^2 \frac{2\pi}{q^4} \frac{S}{V}$$
  
internal surface area

Combination of Porod's law & Invariant

$$\pi \cdot \frac{\lim_{q \to \infty} I(q)q^4}{Q} = \frac{S}{V}$$
surface-volume ratio

important for the characterization of porous materials



# Intensity for random particle system

Scattering intensity: 
$$I(q) = 4\pi \int_0^\infty \gamma_0(r) \frac{\sin(qr)}{qr} r^2 dr$$

Pair distance distribution function :PDDF  $p(r) = r^2 \gamma_0(r)$ 

the set of distances joining the volume elements within a particle, including the case of non-uniform density distribution.

Particle's SHAPE and maximum DIMENSION.



### Spherical particle





### Cylindrical particle







### Flat particle







### Ellipsoids









### Two ellipsoid = dimer







# **Diffraction from Periodic Structure**



Diffraction Intensity:  $I(q) \sim |G(q)|^2 |F(q)|^2$ Laue function:  $|G(q)|^2 = \frac{\sin^2(\pi Nq \cdot r)}{\sin^2(\pi q \cdot r)}$ 

- Maximum ∼ N<sup>2</sup>
- ∞ FWHM ~ 2π/N
  - FWHM --> Size of crystal



### Laue Function



Crystal size --> Intensity & FWHM of diffraction

### Imperfection of crystal (2D)





### Imperfection of 1st kind

Thermal fluctuation etc.

### **Imperfection of 2nd kind**

in the case of soft matter



### Imperfection of crystal



### Imperfection of 2nd kind





# Imperfection of lattice (1D) Perfect lattice

Effect of imperfections on diffraction ?



### **Diffraction from lattice-structure**



*z*(*r*) with imperfection ---> calculate *Z*(*q*)



### Imperfection of 1st kind



: distribution function  
Fourier trans. 
$$P(q)$$

Diffraction with imperfection: 
$$|Z(q)|^2 = N\left[1 - |P(q)|^2\right] + |P(q)|^2 \frac{Z_0(q)}{\sqrt{1-\frac{1}{3}\sigma^2 q^2}}$$
 ideal lattice

- decrease diffraction intensity (no effect on FWHM)

- background at larger angle diffraction



### Imperfection of 2nd kind



# **Decrease** of diffraction intensity and **Increase** of FWHM



R. Hosemann, S. N. Bagchi, *Direct Analysis of Diffraction by Matter*, North-Holland, Amsterdam (1962).

### X-ray Source for SAXS

Brilliance -- Product of size and divergence of beam



SAXS with a low divergence and small beam High brilliance beam is required !



### **SAXS** Optics





### SAXS slits





### **Detectors for SAXS**

	Good Point	Drawback
PSPC	<ul> <li>time-resolved</li> <li>photon-counting</li> <li>low noise</li> </ul>	<ul> <li>counting-rate limitation</li> </ul>
Imaging Plate	<ul> <li>wide dynamic range</li> <li>large active area</li> </ul>	• slow read-out
CCD with Image Intensifier	<ul> <li>time-resolved</li> <li>high sensitivity</li> </ul>	<ul> <li>image distortion</li> <li>low dynamic range</li> </ul>
Fiber- tapered CCD	<ul> <li>fast read-out</li> <li>automated measurement</li> </ul>	<ul> <li>not good for time- resolved</li> </ul>

# X-ray CCD detector with Image Intensifier



### **Advanced SAXS**



- hierarchical structure

- anisotropic structure

### Application of paracrystal theory



### Internal structure of wool



H. Ito et al., Textile Res. J. 54, 397-402 (1986).



# Structure of Intermediate Filament



### Diffraction intensity profiles













Nearly Straight (ROC ~ 10cm)



ROC: Radius of Curvature

# Deformation process of spherulite



Local deformation manner of polypropylene during uniaxial elongation process



Combined measurement of polarized microscope and microbeam SAXS/WAXD.



### Deformation model of PP



Y. Nozue, Y. Shinohara, Y. Ogawa et al., Macromolecules, 40, 2036 (2007).

# **Grazing Incidence SAXS**

### <u>Advantage</u>

- Surface/interface sensitive (beam footprint).
- In-plane structure and out-of-plane structure can be separated.
- Thin film sample on substrate can be measured.

### Ex: from Web page of Dr. Smiligies @ CHESS



### USAXS using medium-length beamline





# USAXS patterns from elongated rubber



TEM image

Rubber filled with spherical silica



Scattering pattern also shows hysteresis.



Y. Shinohara et al., J. Appl. Cryst., **40**, s397 (2007). 55

### Structural information from USAXS



### X-ray Photon Correlation Spectroscopy: XPCS

Measurement of fluctuation of X-ray scattering intensity
 --> Structural fluctuation in sample



### Dynamics of nanoparticles observed with XPCS



- Type of nano-particles
- Temperature

etc.

Time /sec Dynamics of Filler in Rubber

68 100

68

10

1.010

1.000

1





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